

**Search Notes**

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10/767,446

Examiner

Chuck Huynh

Applicant(s)/Patent under  
Reexamination

BARCLAY ET AL.

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
Updated	Search	2/17/2007	CH
455	428	2/16/2007	CH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Class/Subclass	2/16/2007	CH
Combined Text Search	2/16/2007	CH